## Notice of References Cited Application/Control No. 10/512,039 Examiner James A. Meyers Applicant(s)/Patent Under Reexamination MIWA ET AL. Art Unit Page 1 of 1 U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-6,201,882	03-2001	Tanaka, Mikio	382/106
	В	US-			
- Total	С	US-			
	D	US-			
	E	US-			
	E	US-			
Y.	G	US-			·
	Н	US-			
	1	US-			
	J	US-			
	К	US-			
- 7	L	US-			
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Ρ					
	α					
	R					
	s					
	۲					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	w	
	x	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.